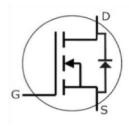


## Wolfspeed SiC Gen 2nd MOSFET

#### **Description**

This is the Wolfspeed's 2nd generation of high performance silicon carbide MOSFET in a packageless bare die format to be implemented into any custom module design. The high blocking voltage with low on-resistance, high speed switching with low capacitance make this MOSFET ideal for high frequency switching application including solar inverters and motor drives.





Package Types: Bare Die PN's: CPM2-1200-0080A

#### **Features**

- Enhanced 2nd Generation SiC MOSFET
- High blocking voltage with low on-resistance
- High speed switching with low capacitance
- Fast intrinsic diode with low reverse recovery

#### **Applications**

- Server & Telecom PSU
- Motor Drives
- Solar Inverters
- SMPS
- DC/DC Converters

#### **Absolute Maximum Ratings**

Stress beyond those listed under absolute maximum ratings may damage the device.

Parameter	Symbol		Rating	Unit
Drain-Source Voltage, across T <sub>vj</sub>	V <sub>DS</sub> (max)		1200	V
Maximum Gate-Source Voltage, Peak Transient Capability	V <sub>GS(max)</sub>		-10/+25	V
Continuous Drain Current, V <sub>GS</sub> = 15V, assumes die packaged in		$T_c = 25^{\circ}C$	36	
TO-247 package with R <sub>th(j-c)</sub> < 0.65 K/W	ID	$T_c = 100$ °C	24	A
Pulsed Drain Current, tp limited by Tvj(max)	ID(pulse)		80	Α
Virtual Junction and Storage Temperature	TvJ, Tstg		-55 to +150	°C
Maximum Processing Temperature, in non-reactive ambient	T <sub>proc</sub>		325	°C

### **Recommended Operating Conditions**

The information in this document is subject to change without notice.

Parameter	Symbol	Rating	Unit
Recommended Operating Gate - Source Voltage	V <sub>G</sub> S(op)	-5/+20	V

## Electrical Characteristics (T<sub>VJ</sub> = 25°C)

Characteristics	Symbol	Min.	Тур.	Max.	Unit	Test Conditions
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	1200			V	$V_{GS} = 0 \text{ V}, I_D = 100 \mu\text{A}$
	,,	2	2.9	4	V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>DS</sub> = 5 mA
Gate Threshold Voltage	V <sub>GS(th)</sub>		2.4		V	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>DS</sub> = 5 mA, T <sub>VJ</sub> = 150°C
Zero Gate Voltage Drain Current	loss		1	100	μΑ	V <sub>DS</sub> = 1200 V, V <sub>GS</sub> = 0 V
Gate-Source Leakage Current	Igss			250	nA	V <sub>GS</sub> = 20 V, V <sub>DS</sub> = 0 V
D : C . O C: I D : I	_		80	98	_	V <sub>GS</sub> = 20 V, I <sub>D</sub> = 20 A
Drain-Source On-State Resistance	R <sub>DS(on)</sub>		144		mΩ	V <sub>GS</sub> = 20 V, I <sub>D</sub> = 20 A, T <sub>VJ</sub> = 150°C
Transconductance			10			V <sub>DS</sub> = 20 V, I <sub>DS</sub> = 20 A
Transconductance	<b>g</b> fs		9		S	V <sub>DS</sub> = 20 V, I <sub>DS</sub> = 20 A, T <sub>VJ</sub> = 150°C
Input Capacitance	Ciss		1130			V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 1000 V f = 1 MHz
Output Capacitance	Coss		92		pF	
Reverse Transfer Capacitance	Crss		7.5		]	V <sub>AC</sub> = 25 mV
Coss Stored Energy	E <sub>oss</sub>		50		μJ	V <sub>DS</sub> = 1000 V, f = 1 MHz
Internal Gate Resistance	R <sub>G(int)</sub>		3.9		Ω	f = 1 MHz, V <sub>AC</sub> = 25 mV
Gate to Source Charge	Qgs		17		nC	$V_{DS} = 800 \text{ V}, V_{GS} = -5 \text{ V}/20 \text{ V}$ $I_{DS} = 20 \text{ A}$ Per IEC60747-8-4 pg 21
Gate to Drain Charge	Q <sub>gd</sub>		29			
Total Gate Charge	Qg		71			

## Reverse Diode Characteristics (T<sub>VJ</sub> = 25 °C)

Characteristics	Symbol	Тур.	Max.	Unit	Test Conditions
Diode Forward Voltage	V <sub>SD</sub>	4.3		V	V <sub>GS</sub> = -5 V, I <sub>SD</sub> = 10 A
Diode Forward Voltage	VSD	3.8		V	V <sub>GS</sub> = -5 V, I <sub>SD</sub> = 10 A, T <sub>VJ</sub> = 150 °C
Reverse Recovery Time	trr	24		ns	
Reverse Recovery Charge	Qrr	152		nC	$V_{GS} = -5 \text{ V}, I_{SD} = 20 \text{ A}, V_{R} = 800 \text{ V}$ dif/dt = 2400 A/ $\mu$ s
Peak Reverse Recovery Current	Irrm	10		А	

#### **Typical Performance**

All the graphs are based on a die placed in a TO-247-4L package.

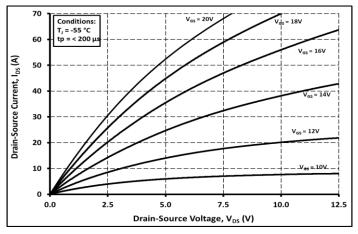


Figure 1.

Output Characteristics T<sub>vj</sub> = -55 °C

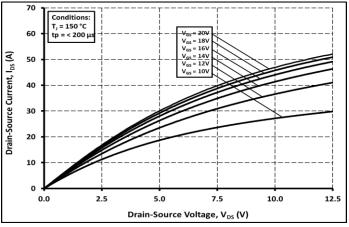


Figure 3.

Output Characteristics T<sub>vj</sub> = 150 °C

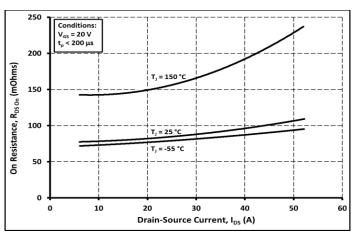


Figure 5.

On-Resistance vs. Drain Current For Various Temperatures

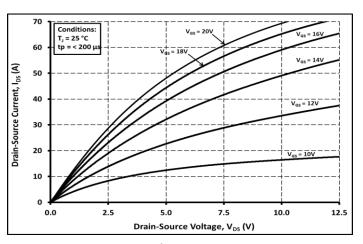


Figure 2.

Output Characteristics T<sub>vi</sub> = 25 °C

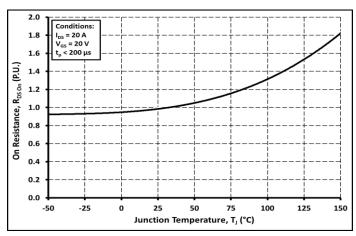


Figure 4.

Normalized On-Resistance vs. Temperature

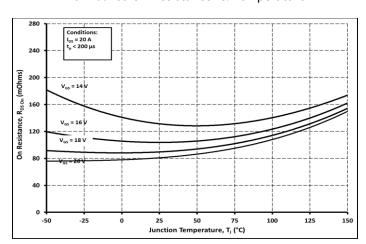


Figure 6.

On-Resistance vs. Temperature For Various Gate Voltages

#### **Typical Performance**

All the graphs are based on a die placed in a TO-247-4L package.

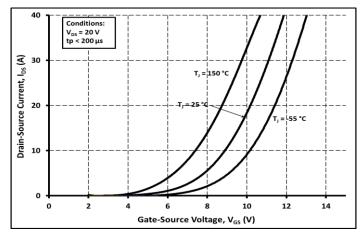


Figure 7.

Transfer Characteristic For Various Junction Temperatures

Figure

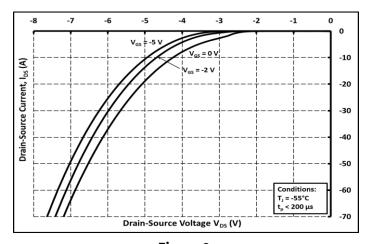


Figure 8.

Body Diode Characteristic at T<sub>vj</sub> = -55 °C

0

0

-10

-20

-30

-40

-50

-60

Conditions:

T<sub>j</sub> = 150°C t<sub>p</sub> < 200 μs

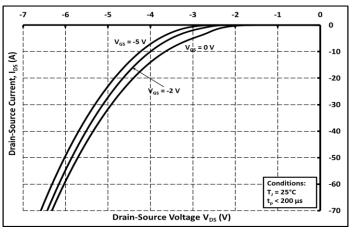


Figure 9.

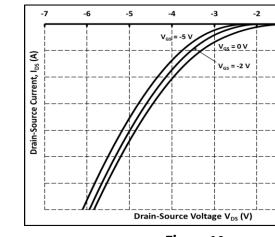


Figure 10.

Body Diode Characteristic at T<sub>vj</sub> = 150 °C

Body Diode Characteristic at T<sub>vj</sub> = 25 °C

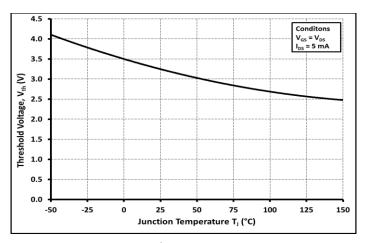


Figure 11.

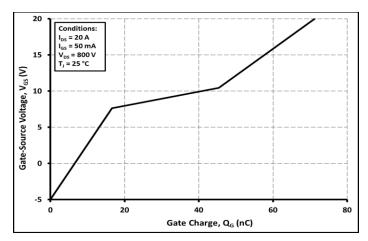


Figure 12.

**Gate Charge Characteristics** 

Threshold Voltage vs. Temperature

#### **Typical Performance**

All the graphs are based on a die placed in a TO-247-4L package.

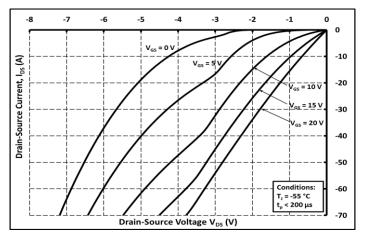


Figure 13.

3rd Quadrant Characteristic at T<sub>vj</sub> = -55 °C

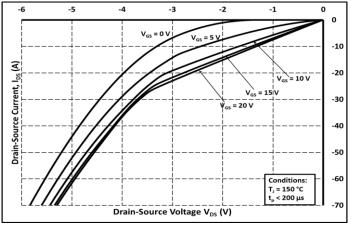


Figure 15.

3rd Quadrant Characteristic at T<sub>vj</sub> = 150 °C

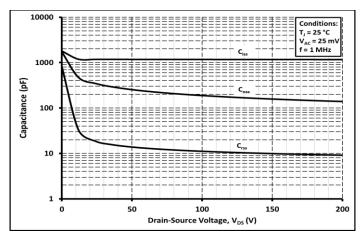


Figure 17.

Capacitances vs. Drain-Source Voltage (0-200V)

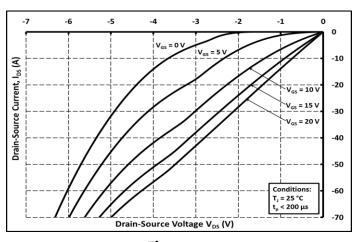


Figure 14.

3rd Quadrant Characteristic at T<sub>vj</sub> = 25 °C

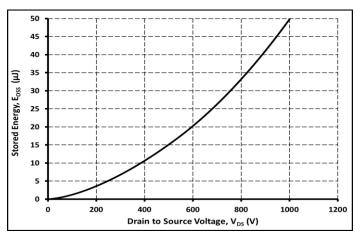


Figure 16.

**Output Capacitor Stored Energy** 

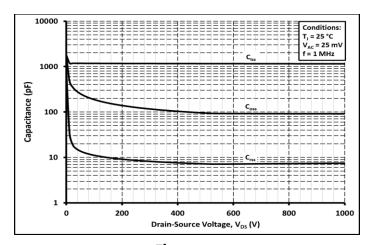
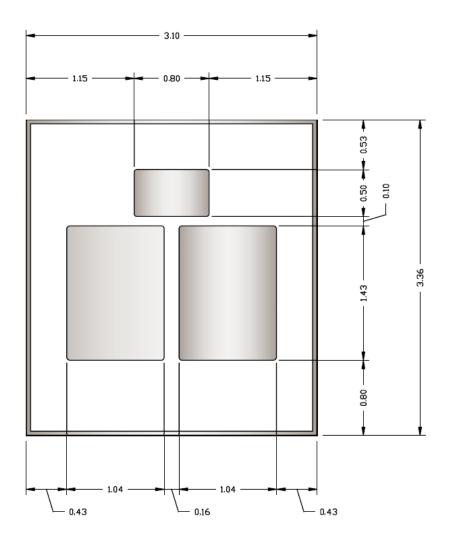


Figure 18.

Capacitances vs. Drain-Source Voltage (0-1200V)

#### **Product Dimensions CPM2-1200-0080A**



### **Product Dimensions CPM2-1200-0080A**

Parameter	Typical	Units
Die Size (L x W)	3.10 x 3.36	mm
Exposed Source Pad Metal Dimensions	1.04 x 1.43	mm
Gate Pad Dimensions	0.80 x 0.50	mm
Chip Thickness <sup>1</sup>	180 ± 20	μт
Frontside (Source) metalization (Al)	4	μm
Frontside (Gate) metalization (Al)	4	μm
Backside (Drain) metalization (Ni:Au)	0.8 / 0.6	μm

<sup>&</sup>lt;sup>1</sup> SiC wafer thickness

## **Product Ordering Information**

Order Number	Description	Package
CPM2-1200-0080A-FY6	SiC MOSFET G2 IND 1200V/80mO UV MLT	Bare Die Product

### **Revision History**

Revision History	Date of Change	Brief Summary
1	09/2020	Initial Release
2	12/22/2023	Template updated

#### Notes & Disclaimer

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